Power MOSFET

30 V, 3.9 A, Dual N-Channel ChipFET™

Features

- Planar Technology Device Offers Low RDS(on) and Fast Switching Speed
- Leadless ChipFET Package has 40% Smaller Footprint than TSOP-6. Ideal Device for Applications Where Board Space is at a Premium.
- ChipFET Package Exhibits Excellent Thermal Capabilities. Ideal for Applications Where Heat Transfer is Required.
- These Devices are Pb-Free and are RoHS Compliant

Applications

- DC-DC Buck or Boost Converters
- Low Side Switching
- Optimized for Battery and Low Side Switching Applications in Computing and Portable Equipment

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Parame | Symbol | Value | Unit | | | |
|---|--------------------------------------|-----------------------|-----------------|------|---|--|
| Drain-to-Source Voltage | V _{DSS} | 30 | V | | | |
| Gate-to-Source Voltage | | | V _{GS} | ±20 | V | |
| Continuous Drain | Steady | $T_A = 25^{\circ}C$ | I _D | 2.9 | А | |
| Current (Note 1) | State | T _A = 85°C | | 2.1 | | |
| | $t \le 5 s$ | T _A = 25°C | | 3.9 | | |
| Power Dissipation (Note 1) | Steady State | T _A = 25°C | P _D | 1.13 | W | |
| | t≤5 s | | | 2.1 | | |
| Continuous Drain | | $T_A = 25^{\circ}C$ | Ι _D | 2.2 | А | |
| Current (Note 2) | Steady | T _A = 85°C | | 1.6 | | |
| Power Dissipation (Note 2) | State | $T_A = 25^{\circ}C$ | P _D | 0.64 | W | |
| Pulsed Drain Current | t _p = | = 10 μs | I _{DM} | 12 | А | |
| ESD Capability (Note 3) | ESD- HBM | 125 | V | | | |
| Operating Junction and S | T _J , T _{STG} | –55 to 150 | °C | | | |
| Source Current (Body Di | ا _S | 2.5 | А | | | |
| Lead Temperature for So (1/8" from case for 10 s) | ΤL | 260 | °C | | | |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

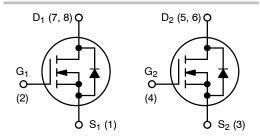
- 1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- 2. Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.214 in sq).
- 3. ESD Rating Information: HBM Class 0.



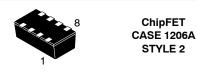
ON Semiconductor[®]

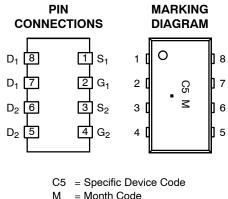
http://onsemi.com

| V _{(BR)DSS} | R _{DS(on)} TYP | I _D MAX | |
|----------------------|-------------------------|--------------------|--|
| 30 V | 80 mΩ @ 10 V | | |
| 00 1 | 110 mΩ @ 4.5 V | 0.077 | |



N-Channel MOSFET





⁼ Month Code

= Pb-Free Package

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|--------------|----------------------|-----------------------|
| NTHD4502NT1G | ChipFET (Pb-Free) | 3000/Tape & Reel |

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Max | Unit |
|---|-----------------|-----|------|
| Junction-to-Ambient - Steady State (Note 4) | $R_{	hetaJA}$ | 110 | °C/W |
| Junction-to-Ambient – t \leq 5 s (Note 4) | $R_{	hetaJA}$ | 60 | |
| Junction-to-Ambient - Steady State (Note 5) | $R_{	hetaJA}$ | 195 | |
| Junction-to-Foot - Steady State (Note 5) | $R_{\theta JF}$ | 40 | |

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.214 in sq).

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

| Parameter | Symbol | Test Conditions | Min | Тур | Max | Units |
|-----------------------------------|----------------------|---|-----|------|------|-------|
| OFF CHARACTERISTICS | | • | | | • | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I _D = 250 μ A | 30 | 36 | | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V_{GS} = 0 V, V_{DS} = 24 V | | | 1.0 | μΑ |
| | | V_{GS} = 0 V, V_{DS} = 24 V, T_{J} = 125°C | | | 10 | |
| Gate-to-Source Leakage Current | I _{GSS} | V_{DS} = 0 V, V_{GS} = ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 6) | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | V_{GS} = V_{DS} , I_D = 250 μ A | 1.0 | 1.65 | 3.0 | V |
| Drain-to-Source On-Resistance | R _{DS(on)} | V_{GS} = 10 V, I _D = 2.9 A | | 78 | 85 | mΩ |
| | | V_{GS} = 4.5 V, I _D = 2.2 A | | 105 | 140 | |
| Forward Transconductance | 9 _{FS} | V _{DS} = 15 V, I _D = 2.9 A | | 3.8 | | S |
| CHARGES AND CAPACITANCES | • | · | | | | |
| Input Capacitance | C _{ISS} | | | 140 | | pF |
| Output Capacitance | C _{OSS} | V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V | | 53 | | |
| Reverse Transfer Capacitance | C _{RSS} | | | 16 | | |
| Input Capacitance | C _{ISS} | | | 135 | 250 | pF |
| Output Capacitance | C _{OSS} | V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 24 V | | 42 | 75 | |
| Reverse Transfer Capacitance | C _{RSS} | | | 13 | 25 | |
| Total Gate Charge | Q _{G(TOT)} | | | 3.6 | 7.0 | nC |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 10 V, V _{DS} = 15 V, | | 0.3 | | |
| Gate-to-Source Charge | Q _{GS} | I _D = 2.9 A | | 0.6 | | |
| Gate-to-Drain Charge | Q _{GD} | 1 | | 0.7 | | |
| Total Gate Charge | Q _{G(TOT)} | | | 1.9 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 4.5 V, V _{DS} = 24 V, | | 0.3 | | 1 |
| Gate-to-Source Charge | Q _{GS} | $V_{GS} = 4.5 \text{ V}, V_{DS} = 24 \text{ V},$ $I_{D} = 2.9 \text{ A}$ | | 0.6 | | |
| Gate-to-Drain Charge | Q _{GD} | 1 | | 0.9 | | |

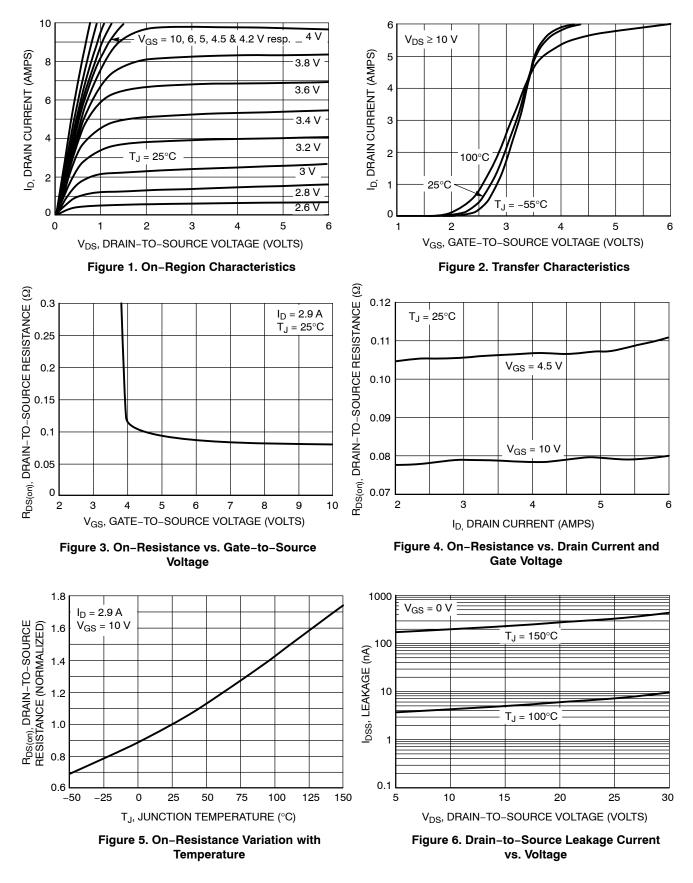
6. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

ELECTRICAL CHARACTERISTICS (continued) (T_J = $25^{\circ}C$ unless otherwise noted)

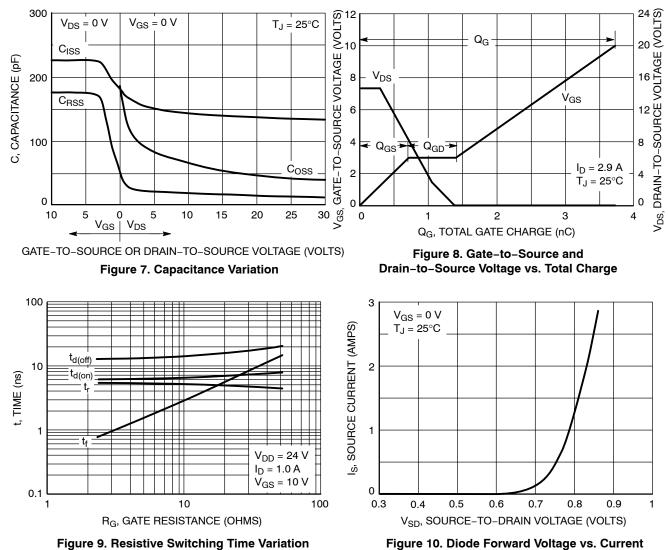
| Parameter Symbol | | Test Conditions | | Тур | Max | Units |
|------------------------------|---------------------|---|--|------|-----|-------|
| DRAIN-SOURCE DIODE CHARACT | TERISTICS | | | • | | |
| Forward Diode Voltage | V _{SD} | $V_{GS} = 0 V, I_{S} = 2.5 A$ | | 0.85 | 1.2 | V |
| Reverse Recovery Time | t _{RR} | V _{GS} = 0 V, I _S = 2.9 A, | | 8.6 | | ns |
| Reverse Recovery Charge | Q _{RR} | dl _S /dt = 100 A/μs | | 4.0 | | nC |
| Reverse Recovery Time | t _{RR} | V _{GS} = 0 V, I _S = 1.0 A, | | 8.4 | | ns |
| Reverse Recovery Charge | Q _{RR} | dl _S /dt = 100 A/µs | | 4.0 | | nC |
| SWITCHING CHARACTERISTICS (I | Note 7) | | | | | |
| Turn-On Delay Time | t _{d(ON)} | | | 6.5 | 12 | ns |
| Rise Time | t _r | V _{GS} = 10 V, V _{DD} = 24 V, | | 5.4 | 10 | 1 |
| Turn-Off Delay Time | t _{d(OFF)} | $\begin{array}{l} V_{\mathrm{GS}} = 10 \; V, \; V_{\mathrm{DD}} = 24 \; V, \\ I_{\mathrm{D}} = 1 \; A, \; R_{\mathrm{G}} = 6 \; \Omega \end{array}$ | | 14.9 | 25 | |
| Fall Time | t _f | | | 1.8 | 5.0 | |
| Turn-On Delay Time | t _{d(ON)} | | | 7.8 | | ns |
| Rise Time | tr | V _{GS} = 4.5 V, V _{DD} = 24 V, | | 12.6 | | |
| Turn-Off Delay Time | t _{d(OFF)} | $I_{\rm D}$ = 2.9 A, $R_{\rm G}$ = 2.5 Ω | | 9.6 | | |
| Fall Time | t _f | | | 2.8 | | 1 |

7. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES

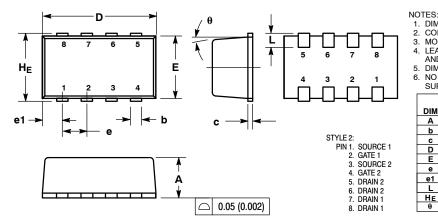


vs. Gate Resistance

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PACKAGE DIMENSIONS

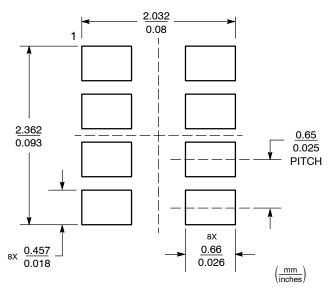
ChipFET[™] CASE 1206A-03 **ISSUE K**



| 3 4 5 | CONTROLLING DIMENSION: MILLINE TER. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE. | | | | | | | | | |
|-------------|--|--------------------|----------|------|-----------|-------|-------|--|--|--|
| [| MILLIMETERS INCHES | | | | | | | | | |
| | DIM | MIN | NOM | MAX | MIN | NOM | MAX | | | |
| [| Α | 1.00 | 1.05 | 1.10 | 0.039 | 0.041 | 0.043 | | | |
| [| b | 0.25 | 0.30 | 0.35 | 0.010 | 0.012 | 0.014 | | | |
| | С | 0.10 | 0.15 | 0.20 | 0.004 | 0.006 | 0.008 | | | |
| | D | 2.95 | 3.05 | 3.10 | 0.116 | 0.120 | 0.122 | | | |
| [| Е | 1.55 | 1.65 | 1.70 | 0.061 | 0.065 | 0.067 | | | |
| [| е | 0.65 BSC 0.025 BSC | | | | | | | | |
| | e1 | | 0.55 BSC | | 0.022 BSC | | | | | |
| | Ĺ | 0.28 | 0.35 | 0.42 | 0.011 | 0.014 | 0.017 | | | |
| [| HE | 1.80 | 1.90 | 2.00 | 0.071 | 0.075 | 0.079 | | | |
| [| θ | 5° NOM 5° NOM | | | | | | | | |

DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.

SOLDERING FOOTPRINT



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